



CAMCOR

Oregon's High-Tech Extension Service



Pacific Northwest Thin Film and Particle Workshop for High Tech Industry

Focus on instrumental methods and applications for characterization of thin films and nano-particles using a wide variety of instrumental techniques including XRD, XPS, EPMA, TEM, FIB, SIMS and Auger. Application oriented presentations by analytical experts and applied materials scientists at University of Oregon, Oregon State University and Portland State University

Thursday, May 14th, 2009
Lorry I. Lokey Laboratories
University of Oregon, Eugene, Oregon

8:30AM-3:00PM

Lunch will be provided

For more information please contact:

Paula Matano

pmatano@uoregon.edu

541-346-4580

A one day workshop emphasizing real world solutions to thin film and nano-particle characterization using the latest analytical methods, instrumental techniques, and software algorithms. Workshop will be held in the new Integrated Science Complex, Lorry I. Lokey Laboratory.

Presentations:

Dave Johnson, University of Oregon, Department of Chemistry

Doug Keszler, Oregon State University, Department of Chemistry

John Donovan, University of Oregon, CAMCOR

Steve Golledge, University of Oregon, CAMCOR

Kurt Langworthy, University of Oregon, CAMCOR

Mark Lonergan, University of Oregon, Department of Chemistry

Jim Hutchison, University of Oregon, Department of Chemistry

Janet Tate, Oregon State University, Department of Physics

Dave Schut, Voxel, Inc

Peter Moeck, Portland State University, Department of Physics

Student Poster Session
Instrument Demonstrations
Technical Preparations